

**Search Notes**

Application/Control No.

10/710,881

Examiner

Hanh Phan

Applicant(s)/Patent under  
Reexamination

FREDERIKSEN ET AL.

Art Unit

2613

**SEARCHED**

Class	Subclass	Date	Examiner
398	193	06/14/07	HP
	194,159		
	195,182		
	183,186		
	192		
330	149	06/14/07	HP
327	317,806	06/14/07	HP
	318		
375	296	06/14/07	HP

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Eastards see attached point out in the file.	06/14/07	HP
ieee search jpo search		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner